


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578521	<b>Applicant(s)/Patent Under Reexamination</b>  CHUN, JONG-YOON
	<b>Examiner</b>  SUCHIRA PANDE	<b>Art Unit</b>  1637

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SEARCH NOTES		
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Inventor name search in PALM	9/10/2008	SP
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